

Search Notes



Application/Control No.

10/764,734

Examiner

Bena Miller

Applicant(s)/Patent under
Reexamination

CHANG, AO YU

Art Unit

3725

SEARCHED

Class	Subclass	Date	Examiner
144	333,329	9/29/2005	BBM
	380,344		
	345,346		
	348,354		
	350-352		
	355,364		
	369		
52	730.1		
156	250,296		
	61		
428	105-107		
	114,537		

INTERFERENCE SEARCHED

Class	Subclass	Date	Examiner
144	333,329, 380,344, 345,346, 348,354, 350-352, 355,364	9/29/05	BBM
144/369; 52/730.1; 156/250,296,61; 428/105-107,114,537			

SEARCH NOTES (INCLUDING SEARCH STRATEGY)

	DATE	EXMR
STIC Search	9/29/2005	BBM
EAST Search	9/29/2005	BBM